

Search Notes**Application/Control No.**

09/933,038

Examiner

LEE NGUYEN

**Applicant(s)/Patent under
Reexamination**

FUTAGI ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
375	229 230 232 233	11/15/2006	LN
	266		
455	69		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB; USPAT; EPO; JPO; DERWENT) IEEE SEE SEARCH HISTORY	11/15/2006	LN